

Notice of References Cited	Application/Control No. 09/691,004		Applicant(s)/Patent Under Reexamination FORBES ET AL.	
	Examiner Johannes P Mondt		Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,507,673	03-1985	Aoyama et al.	257/324
*	B	US-4,852,062	07-1989	Baker et al.	365/185.15
*	C	US-5,604,700	02-1997	Parris et al.	365/185.1
	D	US-			
	E	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	S.M. Sze, "Physics of Semiconductor Devices" , John Wiley & Sons, second edition 1981; Appendix F (page 848).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.